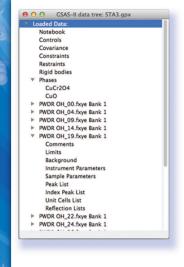
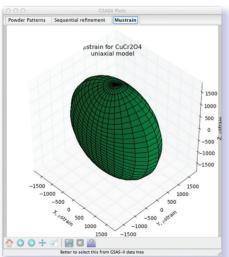
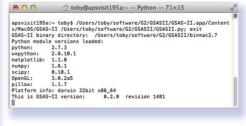
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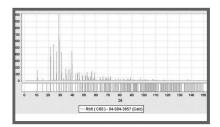








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On the Cover: The GSAS-II user interface. GSAS-II runs with four open windows. In the case shown here, two-phase sequential fits have been made to 17 measurements made as a function of temperature (Courtesy of Brian H. Toby and Robert B. Von Dreele).

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